

**ON Semiconductor®** 

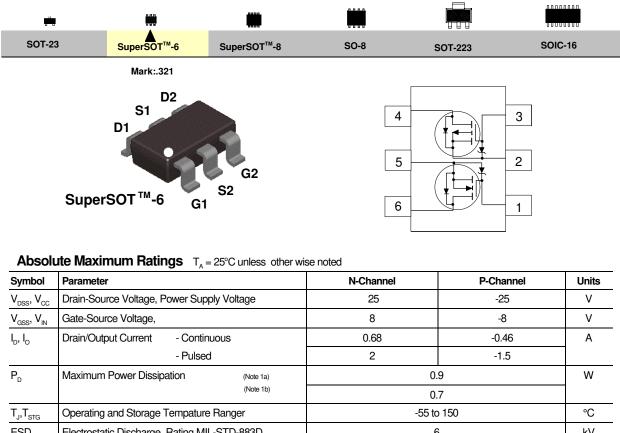
# FDC6321C Dual N & P Channel , Digital FET

## **General Description**

These dual N & P Channel logic level enhancement mode field effect transistors are produced using ON Semiconductor's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. This device has been designed especially for low voltage applications as a replacement for digital transistors in load switching applications. Since bias resistors are not required this dual digital FET can replace several digital transistors with different bias resistors.

### Features

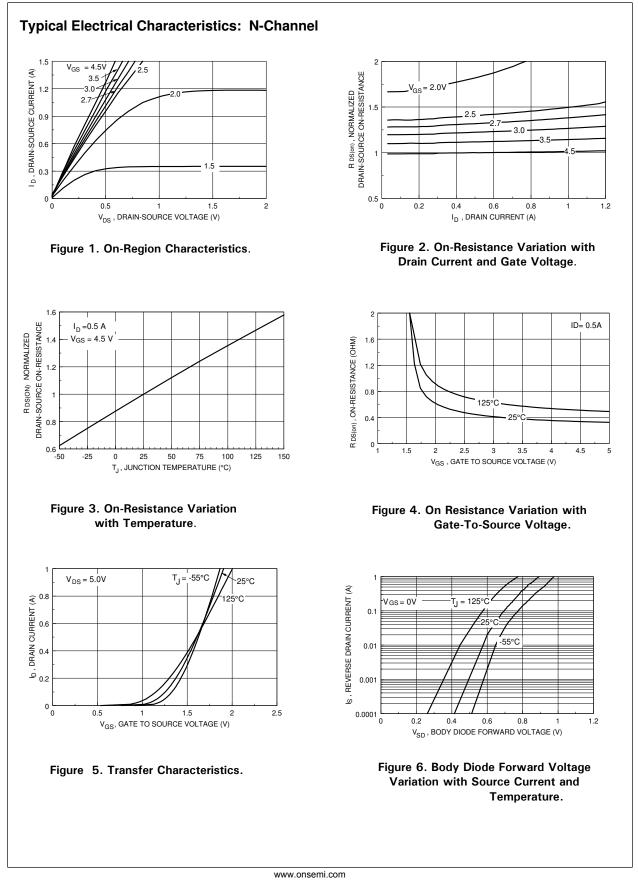
- N-Ch 25 V, 0.68 A,  $R_{DS(ON)} = 0.45 \Omega @ V_{GS} = 4.5 V$
- P-Ch -25 V, -0.46 A, R<sub>DS(ON)</sub> = 1.1 Ω @ V<sub>GS</sub>= -4.5 V.
- Very low level gate drive requirements allowing direct operation in 3 V circuits. V<sub>GS(th)</sub> < 1.0V.</li>
- Gate-Source Zener for ESD ruggedness.
  >6kV Human Body Model
- Replace multiple dual NPN & PNP digital transistors.

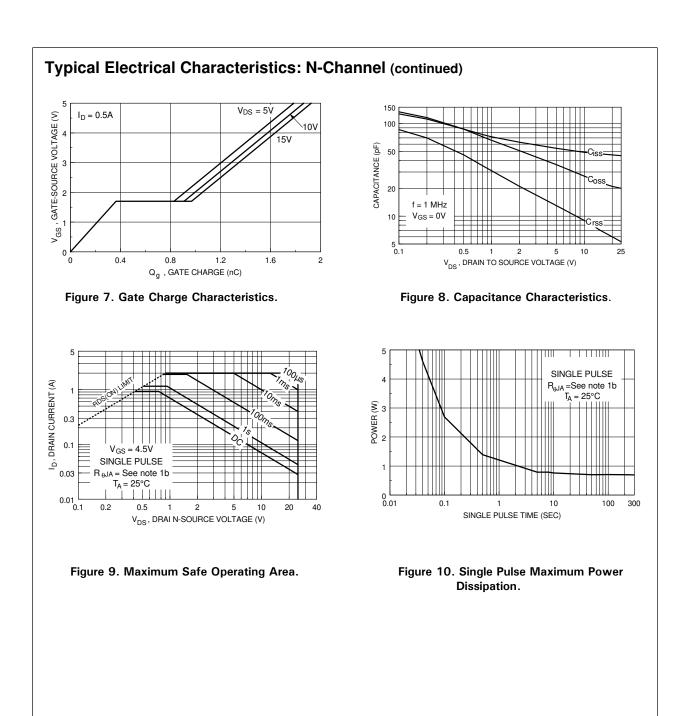


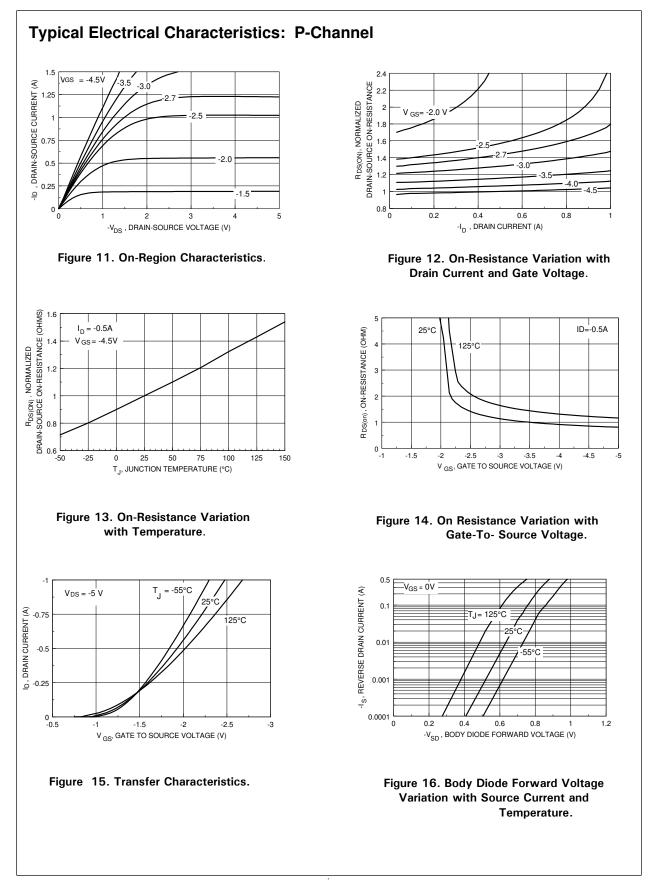
EOD	Human Body Model (100pf / 1500 Ohm)	0	κv
THERM	AL CHARACTERISTICS		
$R_{_{\!\!\!\!\!\!\!\ThetaJA}}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	140	°C/W
$R_{_{\!$	Thermal Resistance, Junction-to-Case (Note 1)	60	°C/W

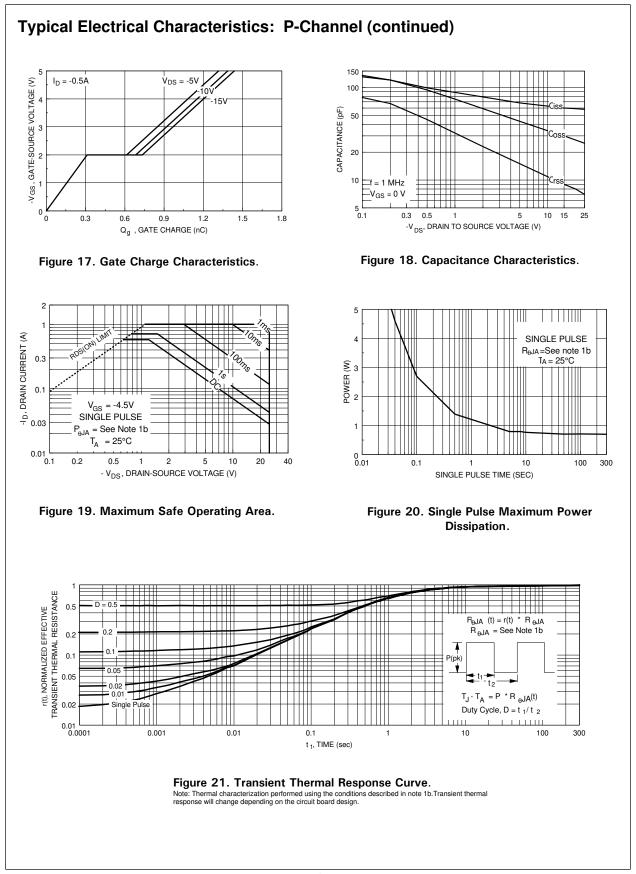
Symbol	Parameter	Conditions		Туре	Min	Тур	Max	Units	
OFF CHAR	ACTERISTICS			. 760					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 250 \mu A$		N-Ch	25			V	
- DSS	Drain Cource Dreakdown Vollage	$V_{GS} = 0 V, I_D = -250 \mu A$		P-Ch	-25				
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temp. Coefficient	$I_{D}$ = 250 µA, Referenced to 25 °C		N-Ch		26		mV /ºC	
		$I_{D}$ = -250 µA, Referenced to 25 °C		P-Ch		-22			
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V},$		N-Ch			1	μA	
		<u>1</u> 3 · 43 ·	T <sub>.1</sub> = 55°C				10		
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V},$	0	P-Ch			-1	μA	
			T <sub>.1</sub> = 55°C				-10		
GSS	Gate - Body Leakage Current	$V_{GS} = 8 V, V_{DS} = 0 V$	<u> </u>	N-Ch			100	nA	
		$V_{GS} = -8 V, V_{DS} = 0 V$		P-Ch			-100	nA	
ON CHARAC	CTERISTICS (Note 2)								
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Temp. Coefficient	$I_{\rm D}$ = 250 $\mu$ A, Referenced	to 25°C	N-Ch		-2.6		mV / °C	
GS(II) J		$I_{p}$ = -250 µA, Referenced	to 25°C	P-Ch		2.1			
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		N-Ch	0.65	0.8	1.5	V	
		$V_{\rm DS} = V_{\rm GS}, \ I_{\rm D} = -250 \ \mu A$		P-Ch	-0.65	-0.86	-1.5		
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, \ \text{I}_{D} = 0.5 \text{ A}$		N-Ch		0.33	0.45	Ω	
. ,			T <sub>J</sub> =125°C			0.51	0.72		
		$V_{GS} = 2.7 \text{ V}, \ I_{D} = 0.25 \text{ A}$				0.44	0.6		
		$V_{\rm GS} = -4.5 \text{ V}, \ I_{\rm D} = -0.5 \text{ A}$		P-Ch		0.87	1.1		
			T <sub>J</sub> =125°C			1.21	1.8		
		$V_{\rm GS} = -2.7 \ V, \ I_{\rm D} = -0.25 \ A$	4			1.22	1.5		
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, \ V_{DS} = 5 \text{ V}$		N-Ch	1			A	
		$V_{GS} = -4.5 V, V_{DS} = -5 V$		P-Ch	-1				
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, \ \text{I}_{D} = \ 0.5 \text{ A}$		N-Ch		1.45		S	
		$V_{\rm DS} = -5 \ V, \ I_{\rm D} = -0.5 \ A$		P-Ch		0.8			
<b>YNAMIC CH</b>	HARACTERISTICS								
C <sub>iss</sub>	Input Capacitance	N-Channel		N-Ch		50		pF	
		$V_{DS}$ = 10 V, $V_{GS}$ = 0 V,		P-Ch		63			
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		N-Ch		28		pF	
		P-Channel		P-Ch		34			
C <sub>rss</sub>	Reverse Transfer Capacitance	$V_{DS}$ = -10 V, $V_{GS}$ = 0V,		N-Ch		9		pF	
		f = 1.0 MHz		P-Ch		10			

	NG CHARACTERISTICS (Note 2)	1						
mbol	Parameter	Conditions		Туре	Min	Тур	Max	Units
t <sub>D(on)</sub>	Turn - On Delay Time	N-Channel		N-Ch		3	6	nS
		$V_{DD} = 6 V, I_{D} = 0.5 A,$		P-Ch		7	20	
	Turn - On Rise Time	$V_{Gs}$ = 4.5 V, $R_{GEN}$ = 50 $\Omega$		N-Ch		8	16	nS
				P-Ch		9	18	
(ff)	Turn - Off Delay Time	P-Channel		N-Ch		17	30	nS
	$V_{DD} = -6 V, I_{D} = -0.5 A,$		P-Ch		55	110		
	Turn - Off Fall Time	$V_{\text{Gen}} = -4.5 \text{ V}, \text{ R}_{\text{GEN}} = 50 \text{ S}$	Ω	N-Ch		13	25	nS
				P-Ch		35	70	
	Total Gate Charge	N-Channel		N-Ch		1.64	2.3	nC
		$V_{\rm DS} = 5 \ V, \ I_{\rm D} = 0.5 \ A,$		P-Ch		1.1	1.5	
s	Gate-Source Charge	$V_{GS} = 4.5 V$		N-Ch		0.38		nC
		P- Channel		P-Ch		0.32		
d	Gate-Drain Charge	$V_{DS} = -5 V,$		N-Ch		0.45		nC
		$I_{\rm D}$ = -0.25 A, $V_{\rm GS}$ = -4.5 V		P-Ch		0.25		
RAIN-SO	URCE DIODE CHARACTERISTICS AN					1		
	Maximum Continuous Drain-Source	Diode Forward Current	Forward Current				0.3	A
				P-Ch			-0.5	
$V_{SD}$	Drain-Source Diode Forward Voltag	$V_{GS} = 0 V, I_S = 0.5 A$ (No		N-Ch		0.83	1.2	V
		$V_{GS} = 0 V$ , $I_{S} = -0.5 A$ (No	T <sub>J</sub> =125°C			0.69	0.85	-
		$V_{GS} = 0 V, I_{S} = -0.5 A$ (No	T, =125°C	P-Ch		-0.89	-1.2	-
	a. 140°C/W on a 0.125 in² pad of 2oz copper.	b. 180°C/W on a 0.005 in² of pad of 2oz copper.						









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